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Application/Control No.	Applicant(s)/Patent under Reexamination
09/811,847	OCHIAI ET AL.
Examiner	Art Unit
Christopher Onuaku	2621

SEARCHED				
Class	Subclass	Date	Examiner	
386	46,65,77,9 5,111,112, 125,126	12/19/2006	coo	
348	14.01	12/19/2006	coo	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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	DATE	EXMR
Thai Tran 386	12/19/2006	coo
Young Lee 348	12/19/2006	coo
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